

Notice of References Cited	Application/Control No. 09/899977	Applicant(s)/Patent Under Reexamination KEETH ET AL.	
	Examiner MICHAEL T. TRAN	Art Unit 2827	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,724,289	03-1998	Watanabe, Hisayoshi	365/201
*	B	US-5,651,011	07-1997	Keeth, Brent	714/724
*	C	US-5,467,468	11-1995	Koshikawa, Yasuji	714/726
*	D	US-5,723,999	03-1998	Merritt, Todd	327/526
*	E	US-5,177,745	01-1993	Rozman, Rodney R.	714/718
*	F	US-5,072,138	12-1991	Slemmer et al.	326/16
*	G	US-4,860,260	08-1989	Saito et al.	365/201
*	H	US-6,473,346	10-2002	Kim et al.	365/201
*	I	US-5,983,375	11-1999	Kim et al.	714/720
*	J	US-5,706,234	01-1998	Pilch et al.	365/201
*	K	US-5,661,729	08-1997	Miyazaki et al.	714/719
*	L	US-5,539,702	07-1996	Ahn, Yeong-Chang	365/210
*	M	US-4,744,061	05-1988	Takemae et al.	365/201

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.